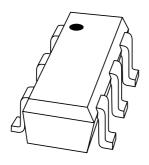
DISCRETE SEMICONDUCTORS

DATA SHEET



BAW101SHigh voltage double diode

Product specification

2003 May 13





Philips Semiconductors

High voltage double diode

BAW101S

Product specification

FEATURES

- Small plastic SMD package
- High switching speed: max. 50 ns
- High continuous reverse voltage: 300 V
- · Electrically insulated diodes.

APPLICATIONS

- · High voltage switching
- Automotive
- Communication.

DESCRIPTION

The BAW101S is a high-speed switching diode array with two separate dice, fabricated in planar technology and encapsulated in a small SOT363 plastic SMD package.

MARKING

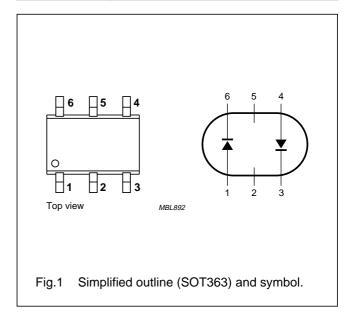
TYPE NUMBER	MARKING CODE(1)
BAW101S	K2*

Note

- 1. * = p: Made in Hong Kong.
 - * = t: Made in Malaysia.
 - * = W: Made in China.

PINNING

PIN	DESCRIPTION	
1	anode 1	
2	n.c.	
3	cathode 2	
4	anode 2	
5	n.c.	
6	cathode 1	



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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT	
Per diode						
V _R	continuous reverse voltage		_	300	V	
		series connection	_	600	V	
V_{RRM}	repetitive peak reverse voltage		_	300	V	
		series connection	_	600	V	
I _F	continuous forward current	single diode loaded; note 1; see Fig.2	_	250	mA	
		double diode loaded; note 1; see Fig.2	_	140	mA	
I _{FRM}	repetitive peak forward current		_	625	mA	
I _{FSM}	non-repetitive peak forward current	square wave; $T_j = 25$ °C prior to surge; $t = 1 \mu s$	_	4.5	А	
P _{tot}	total power dissipation	T _{amb} = 25 °C; note 1	_	350	mW	
T _{stg}	storage temperature		-65	+150	°C	
Tj	junction temperature		_	150	°C	
T _{amb}	operating ambient temperature		-65	+150	°C	

Note

ELECTRICAL CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified.

SYMBOL	PARAMETER CONDITIONS		MIN.	MAX.	UNIT
Per diode					
V _{BR(R)}	reverse breakdown voltage	Ι _R = 100 μΑ	300	_	V
V _F	forward voltage	I _F = 100 mA; note 1	_	1.1	V
I _R	reverse current	V _R = 250 V		150	nA
		V _R = 250 V; T _{amb} = 150 °C	_	50	μΑ
t _{rr}	reverse recovery time	ery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100 \Omega$; measured at $I_R = 3$ mA		50	ns
C _d	diode capacitance	V _R = 0 V; f = 1 MHz –		2	pF

Note

1. Pulse test: pulse width = 300 μ s; δ = 0.02.

^{1.} Device mounted on an FR4 printed-circuit board, cathode-lead mounting pad = 1 cm^2 .

High voltage double diode

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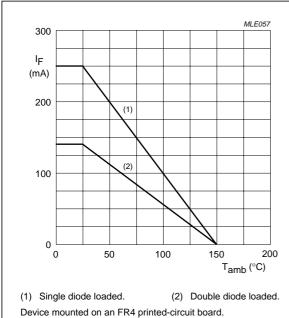
THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-s}	thermal resistance from junction to soldering point	note 1	255	K/W
R _{th j-a}	thermal resistance from junction to ambient	note 2	357	K/W

Notes

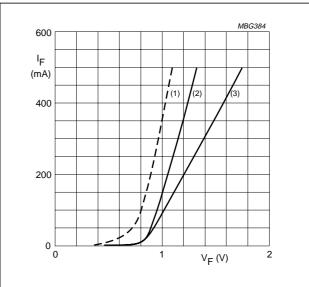
- 1. One or more diodes loaded.
- 2. Device mounted on an FR4 printed-circuit board, cathode-lead mounting pad = 1 cm^2 .

GRAPHICAL DATA



Cathode-lead mounting pad = 1 cm².

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



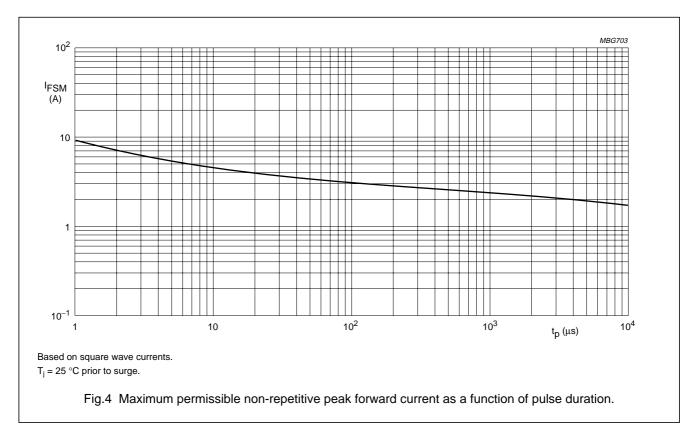
- (1) $T_j = 150$ °C; typical values.
- (2) $T_j = 25$ °C; typical values.
- (3) $T_j = 25$ °C; maximum values.

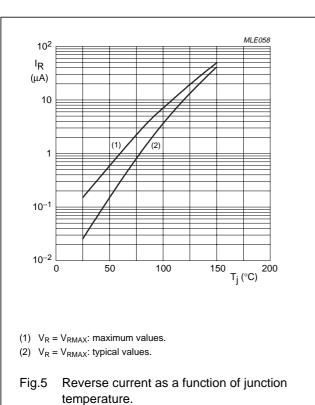
Fig.3 Forward current as a function of forward voltage.

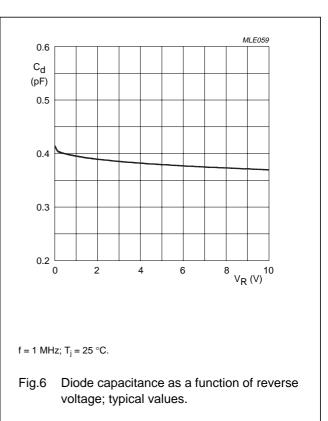
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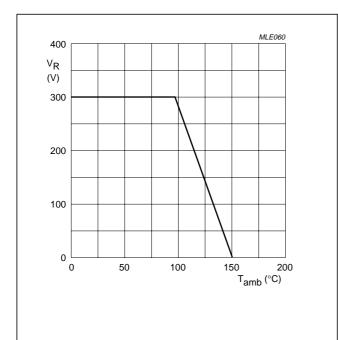


Fig.7 Maximum permissible continuous reverse voltage as a function of ambient temperature.

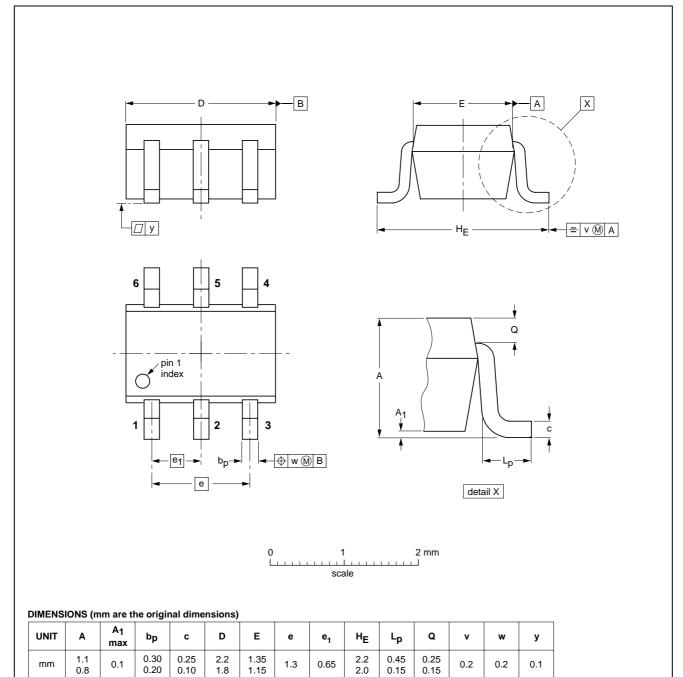
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PACKAGE OUTLINE

Plastic surface mounted package; 6 leads

SOT363



OUTLINE		REFERENCES		EUROPEAN	ICCUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT363			SC-88			97-02-28

0.65

0.2

0.1

1.3

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0.1

0.20

mm

High voltage double diode

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DATA SHEET STATUS

LEVEL	DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS(2)(3)	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

Notes

- 1. Please consult the most recently issued data sheet before initiating or completing a design.
- 2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

DEFINITIONS

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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NOTES

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NOTES